

## Notice of References Cited

Application/Control No.

O9/225,189

Examiner

James M Hannett

Applicant(s)/Patent Under
Reexamination
QIAN, RICHARD J.

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,914,748	06-1999	Parulski et al.	348/239
	В	US-5,382,980	01-1995	Gehrmann, Rainer	348/586
	С	US-5,710,602	01-1998	Gardos et al.	348/255
	D	US-5,574,511	11-1996	Yang et al.	348/586
	Ε	US-6,137,919	10-2000	Gonsalves et al.	348/586
	F	US-5,764,306	06-1998	Steffano, Michael D.	348/552
	G	US-5,808,682	09-1998	Okunoki et al.	348/586
	Н	US-5,684,887	11-1997	Lee et al.	348/586
	1	US-5,923,380	07-1999	Yang et al.	348/586
	J	US-5,937,104	08-1999	Henderson et al.	348/586
	К	US-5,812,787	09-1998	Astle, Brian	348/586
	L	US-5,825,909	10-1998	Jang, Ben Kwei	108/173
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	2					
	0					
	Φ					
	α					
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	٥	
	٧	
	8	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.